Power MOSFET

-60 V, -12 A, P-Channel DPAK

This Power MOSFET is designed to withstand high energy in the avalanche and commutation modes. Designed for low-voltage, highspeed switching applications in power supplies, converters, and power motor controls. These devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer an additional safety margin against unexpected voltage transients.

Features

- Avalanche Energy Specified
- I_{DSS} and V_{DS(on)} Specified at Elevated Temperature
- Designed for Low-Voltage, High-Speed Switching Applications and to Withstand High Energy in the Avalanche and Commutation Modes
- NVD and SVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	-60	Vdc
Gate-to-Source Voltage - Continuous - Non-repetitive (t _p ≤ 10 ms)	V _{GS} V _{GSM}	± 20 ± 25	Vdc Vpk
Drain Current - Continuous @ $T_a = 25^{\circ}C$ - Single Pulse ($t_p \le 10 \text{ ms}$)	I _D I _{DM}	-12 -18	Adc Apk
Total Power Dissipation @ T _a = 25°C	P _D	55	W
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to 175	°C
Single Pulse Drain–to–Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 25 \text{ Vdc}, V_{GS} = 10 \text{ Vdc}, \text{ Peak}$ $I_L = 12 \text{ Apk}, L = 3.0 \text{ mH}, R_G = 25 \Omega$)	E _{AS}	216	mJ
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$egin{array}{c} R_{ heta JC} \ R_{ heta JA} \ R_{ heta JA} \end{array}$	2.73 71.4 100	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in. from case for 10 seconds	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

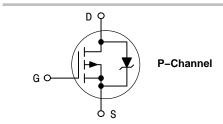
- When surface mounted to an FR4 board using 1 in pad size (Cu area = 1.127 in^2).
- 2. When surface mounted to an FR4 board using the minimum recommended pad size (Cu area = 0.412 in^2).



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-60 V	155 mΩ @ –10 V, 6 A	–12 A



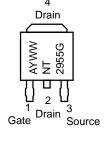


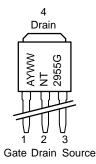




CASE 369D STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS





= Assembly Location*

NT2955/NV2955 = Specific Device Code (DPAK) = Specific Device Code (IPAK) NT2955

WW = Work Week G = Pb-Free Package

* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

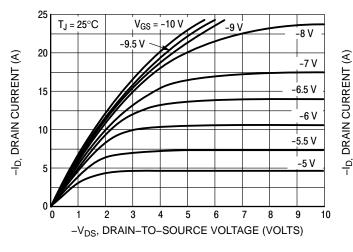
Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•	•	•		
Drain-to-Source Breakdown Voltage (Note 3) (V _{GS} = 0 Vdc, I _D = -0.25 mA) (Positive Temperature Coefficient)			-60 -	- 67	_ _	Vdc mV/°C
Zero Gate Voltage Drain Current (V _{GS} = 0 Vdc, V _{DS} = -60 Vdc, T _J = 25°C) (V _{GS} = 0 Vdc, V _{DS} = -60 Vdc, T _J = 150°C)		I _{DSS}	_ _	_ _	-10 -100	μAdc
Gate-Body Leakage Current (V _{GS}	$_{S} = \pm 20 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	I _{GSS}	-	-	-100	nAdc
ON CHARACTERISTICS (Note 3)		•	•	•	•	•
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = -250 \mu Adc)$ (Negative Temperature Coeffici	ent)	V _{GS(th)}	-2.0 -	-2.8 4.5	-4.0 -	Vdc mV/°C
Static Drain-Source On-State Re (V _{GS} = -10 Vdc, I _D = -6.0 Adc)	sistance	R _{DS(on)}	_	0.155	0.180	Ω
Drain-to-Source On-Voltage ($V_{GS} = -10$ Vdc, $I_D = -12$ Adc) ($V_{GS} = -10$ Vdc, $I_D = -6.0$ Adc, $T_J = 150$ °C)		V _{DS(on)}		-1.86 -	-2.6 -2.0	Vdc
Forward Transconductance (V _{DS}	= 10 Vdc, I _D = 6.0 Adc)	gFS		8.0	_	Mhos
DYNAMIC CHARACTERISTICS		•	•	•	•	•
Input Capacitance		C _{iss}	_	500	750	pF
Output Capacitance	$(V_{DS} = -25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, F = 1.0 \text{ MHz})$	C _{oss}	-	150	250	
Reverse Transfer Capacitance		C _{rss}	-	50	100	
SWITCHING CHARACTERISTICS	(Notes 3 and 4)	•	•			
Turn-On Delay Time		t _{d(on)}	_	10	20	ns
Rise Time	(V _{DD} = -30 Vdc, I _D = -12 A,	t _r	-	45	85	
Turn-Off Delay Time	$V_{GS} = -10 \text{ V, R}_{G} = 9.1 \Omega$	t _{d(off)}	-	26	40	
Fall Time		t _f	-	48	90	
Gate Charge		Q _T	_	- 15	30	nC
	$(V_{DS} = -48 \text{ Vdc}, V_{GS} = -10 \text{ Vdc}, I_{D} = -12 \text{ A})$	$V_{GS} = -10 \text{ Vdc},$ Q_{GS}	_	4.0	_	
	10 12 A)	Q_{GD}	_	7.0	_	
DRAIN-SOURCE DIODE CHARA	CTERISTICS (Note 3)	•	•	•	•	•
Diode Forward On–Voltage ($I_S = 12$ Adc, $V_{GS} = 0$ V) ($I_S = 12$ Adc, $V_{GS} = 0$ V, $T_J = 150$ °C)		V _{SD}		-1.6 -1.3	-2.5 -	Vdc
Reverse Recovery Time (I _S = 12 A, dI _S /dt = 100 A/ μ s ,V _{GS} = 0 V)		t _{rr}	-	50		ns
		ta	_	40	_	
		t _b	-	10	_	
Reverse Recovery Stored Charge		Q _{RR}	1 _	0.10	_	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Indicates Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

4. Switching characteristics are independent of operating junction temperature.

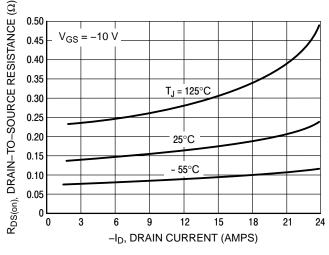
TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



24 $T_J = -55^{\circ}C$ 22 $V_{DS} \ge -10 \text{ V}$ 125°C 20 18 16 14 12 10 0 | 3 8 9 10 -V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



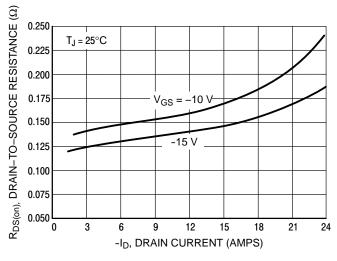
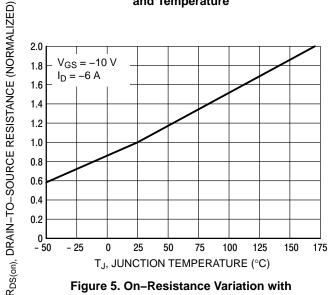


Figure 3. On-Resistance versus Drain Current and Temperature

Figure 4. On-Resistance versus Drain Current and Gate Voltage



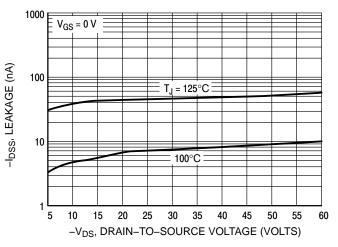
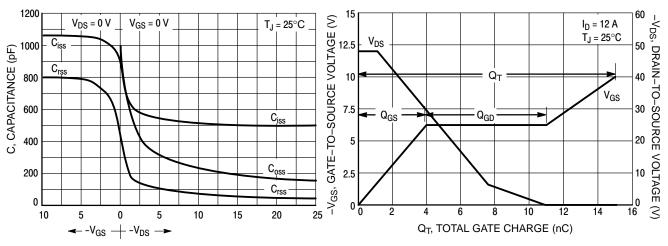


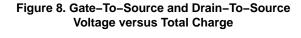
Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-To-Source Leakage **Current versus Voltage**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation



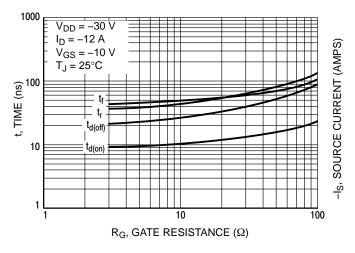


Figure 9. Resistive Switching Time Variation versus Gate Resistance

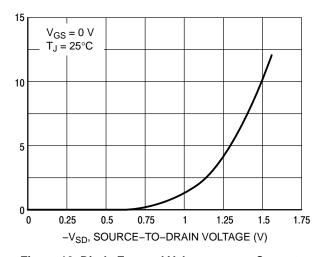


Figure 10. Diode Forward Voltage versus Current

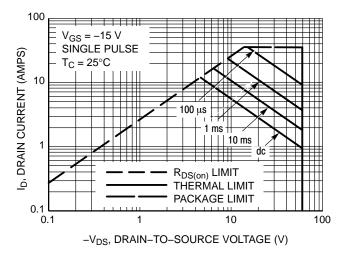


Figure 11. Maximum Rated Forward Biased Safe Operating Area

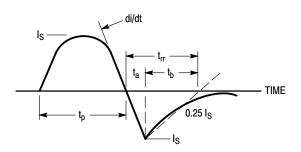


Figure 12. Diode Reverse Recovery Waveform

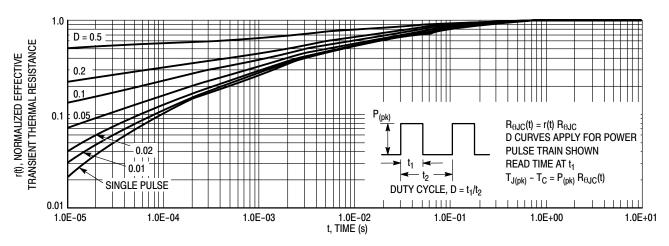


Figure 13. Thermal Response

ORDERING INFORMATION

Device	Package	Shipping [†]
NTD2955G	DPAK (Pb-Free)	75 Units / Rail
NTD2955-1G	IPAK (Pb-Free)	75 Units / Rail
NTD2955T4G	DPAK (Pb-Free)	2500 / Tape & Reel
NVD2955T4G*	DPAK (Pb-Free)	2500 / Tape & Reel
SVD2955T4G*	DPAK (Pb-Free)	2500 / Tape & Reel

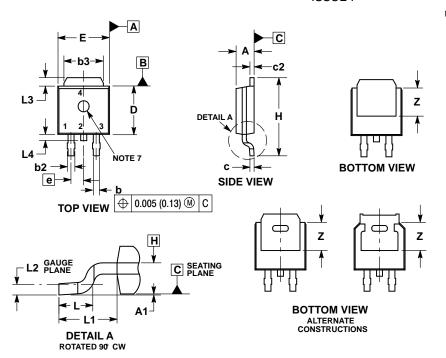
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVD and SVD Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C ISSUE F



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME

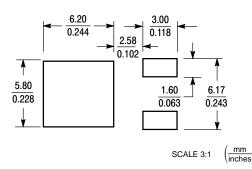
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

- PLANE H.
 7. OPTIONAL MOLD FEATURE.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.086	0.094	2.18	2.38
A1	0.000	0.005	0.00	0.13
b	0.025	0.035	0.63	0.89
b2	0.028	0.045	0.72	1.14
b3	0.180	0.215	4.57	5.46
С	0.018	0.024	0.46	0.61
c2	0.018	0.024	0.46	0.61
D	0.235	0.245	5.97	6.22
E	0.250	0.265	6.35	6.73
е	0.090 BSC		2.29 BSC	
Н	0.370	0.410	9.40	10.41
L	0.055	0.070	1.40	1.78
L1	0.114	0.114 REF		REF
L2	0.020 BSC		0.51 BSC	
L3	0.035	0.050	0.89	1.27
L4		0.040		1.01
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

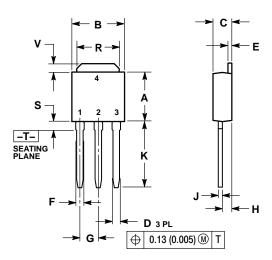
SOLDERING FOOTPRINT*

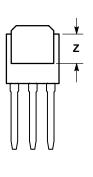


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

IPAK CASE 369D **ISSUE C**





NOTES:

- 1 DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090 BSC		2.29	.29 BSC	
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

STYLE 2:

PIN 1. GATE

- DRAIN
 SOURCE
- DRAIN

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